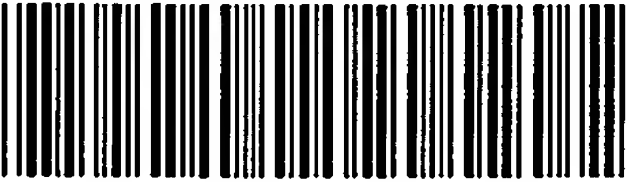


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/642,545	MEYER-GULDNER ET AL.	
	Examiner	Art Unit	
	Donghee Kang	2811	

SEARCHED			
Class	Subclass	Date	Examiner
361	736,737,700,772,776	2/23/2005	KANG
257	697,700	2/23/2005	KANG
257	99-100	2/23/2005	KANG
257	734	2/23/2005	KANG
439	66,76.1-2	2/23/2005	KANG
174	261	2/23/2005	KANG
365	200	2/23/2005	KANG
385	92,53	2/24/2005	KANG
361	777	2/24/2005	KANG
385	56,59	2/24/2005	KANG

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
361	736-737	2/24/2005	KANG
361	772,776	2/24/2005	KANG
361	777	2/24/2005	KANG
257/697,700,734 439/76.1,76.2		2/24/2005	KANG

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST USPTO,USPGPUB,EPO,JPO,DEW,IB MTDB	2/23/2005	KANG
TEXT SEARCH SEE ATTACHED SEARCH HISTORY	2/23/2005	KANG